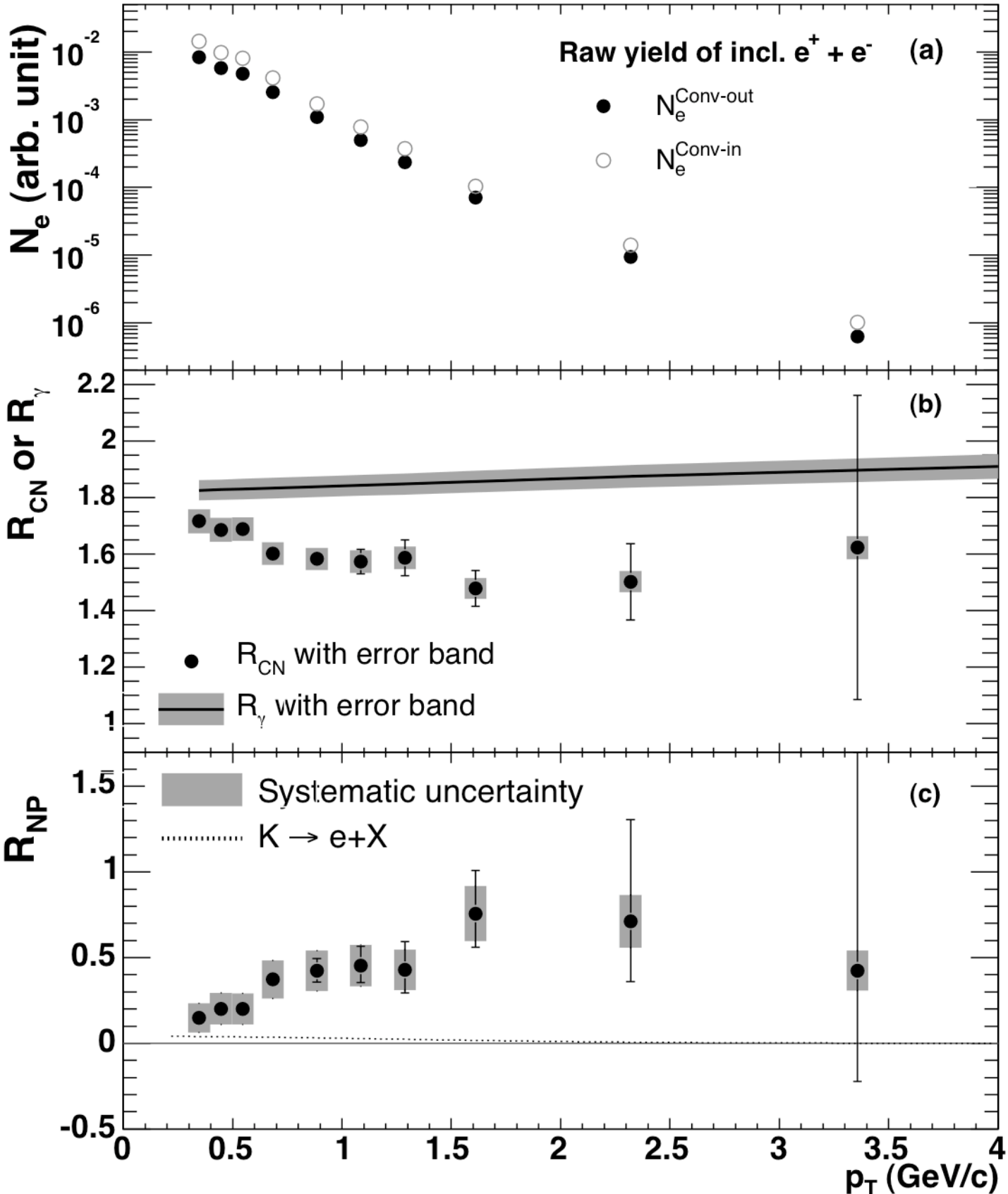
Raw yield of incl. e+ + e-
(a)
N_e^Conv-out
N_e^Conv-in
N_e (arb. unit)
(b)
R_CN or R_γ
R_CN with error band
R_γ with error band
(c)
Systematic uncertainty
K → e+X
R_NP
p_T (GeV/c)